Sophisticated Instrument Centre (SIC) Single Crystal X-Ray Diffraction Facility, IIT Indore

Instrument: Dual Source Super Nova CCD System from Agilent Technologies (Oxford Diffraction)

Crystal Submission Form

Date of submission:	SIC Code*:
	Date of Data Collection*:
	(*Please leave this blank)
User Code	
Name of the Supervisor	
Name of the User	
E-mail address	
Tel no.	
Crystal Information Mp (°C):	
Stability: [] Stable	[] Air sensitive [] Moisture sensitive
Other techniques used for characterisation: [] IR [] Mass spectrum [] NMR	
Starting Materials and Solvent information:	
Structural formula and expected structure (or as close to expected as possible) (Indicate the desired atom-labeling scheme as well)	

Use of Single Crystal X-Ray Diffraction Facility at IIT Indore automatically implies that following acknowledgement will be given by the user whenever either oral or written presentations are made of the results obtained from the facility:

"We are grateful to the Sophisticated Instrument Centre (SIC) Single Crystal X-Ray Diffraction Facility IIT Indore." Further, the user must ensure to send us copies of reprints of publications which contain results obtained from above facility.

Signature of Supervisor: